## STATEMENT ABOUT THE INVENTORS:

Pursuant to 37 C.F.R. §1.63(d)(2) and M.P.E.P. § 602.05(a), Applicants hereby state that the subject matter invented by Harold Heller, Donald Sanders, Paul Van Gompel and Paul Christoffel in this application is no longer included in the pending claims thereof by virtue of this preliminary amendment.

Please amend the list of inventors by deleting the above-named inventors so that the present application lists as inventors:

Mary Anne Bruemmer-Prestley, Sarah Jane Marie Freiburger, Cindy Price, Lori Schutkoske and Suzanne Marie Schmoker.

## IN THE SPECIFICATION:

Please rewrite the paragraph beginning at page 14, line 22 as follows:

The preferred non-woven materials, which are relatively smooth, can be distinguished from other non-woven materials that have been used as loop materials by a comparison of various properties. For example, and referring to FIGS. 12-15, Scanning White-Light Interference Microscopy (SWLIM) tests were performed on two materials, a 0.60 osy wire-weave spunbond laminate material and a 2.0 osy point-unbonded (PUB) material to determine various roughness parameters. The 2D and 3D representations of FIGS. 12-15 are each a 3 x 3 field montage, having a size of about 6.7 mm x 5.1 mm. The measurement information for each representation included a 2.50 magnification, a VSI measurement mode and a 6.72 um sampling. In addition, the measurement information for the representations of FIGS. 12 and 13 included a 995 X 652 array size, while the information for the representations of FIGS. 14 and 15 included a 997 X 634 array size. In addition, with respect to at least the 2-D representations, the processed options for the representations of FIGS. 12 and 14 included low pass filtering, with the "tilt" term removed in the representation of FIG. 12. The results of the SWLIM tests are referenced in Table 1.